


<b>Search Notes</b>  	<b>Application/Control No.</b>  10584639	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  PHUOC DOAN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Attached Updated Search History	03/10/09	PHD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Attached Interferences Search History	03/10/09	PHD

--	--